



Docket No.: M4065.0805/P805
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Kwang-Bo Cho

Allowed: March 23, 2004

Application No.: 10/222,773

Confirmation No.: 6217

Filed: August 16, 2002

Art Unit: 2829

For: ON-CHIP ADC TEST FOR IMAGE
SENSORS

Examiner: T. Q. Nguyen

**COMMENTS ON EXAMINER'S
STATEMENT OF REASONS FOR ALLOWANCE**

MS Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Applicant agrees in part with the Examiner's statement for allowance in that the prior art of record fails to disclose the limitations noted by the Examiner. However, the Examiner's statement does not reflect all of the language of each of the allowed claims. The totality of the language of each claim provides additional reasons for the allowance of each claim.

Dated: November 1, 2004

Respectfully submitted,

By 
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